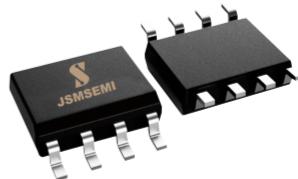


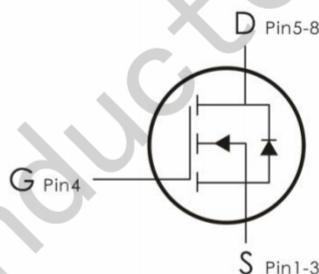
## Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent  $R_{DS(on)}$  with low gate charge. It can be used in a wide variety of applications.



## Features:

- 1)  $V_{DS}=30V, I_D=12A, R_{DS(on)}<8m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low  $R_{DS(on)}$ .
- 5) Excellent package for good heat dissipation.



## Absolute Maximum Ratings: ( $T_a=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain-Source Voltage	30	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current- $T_A=25^\circ C$	12	A
	Continuous Drain Current- $T_A=100^\circ C$	9	
$I_{DM}$	Drain Current-Pulsed <sup>note1</sup>	60	A
$E_{AS}$	Single Pulsed Avalanche Energy <sup>note2</sup>	39	mJ
$P_D$	Power Dissipation	3	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ C$

## Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{JA}$	Thermal Resistance,Junction to Ambient	41	$^\circ C/W$

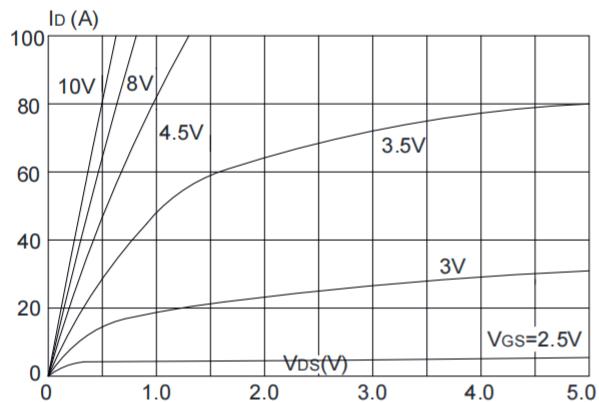
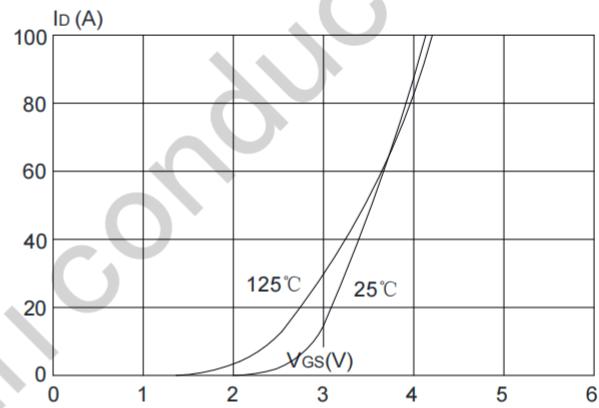
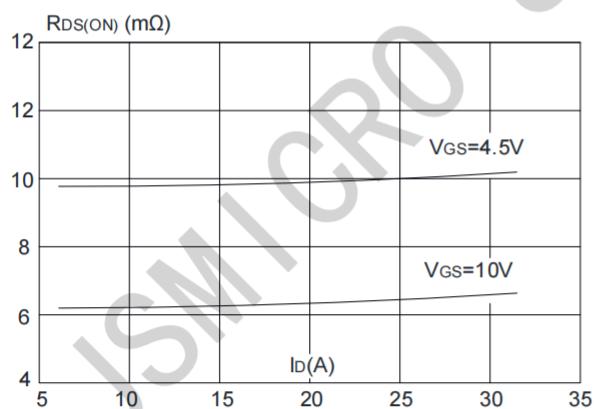
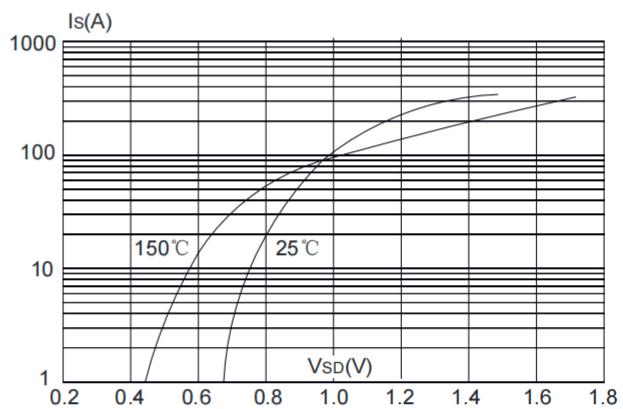
Electrical Characteristics: ( $T_A=25^\circ\text{C}$  unless otherwise noted)

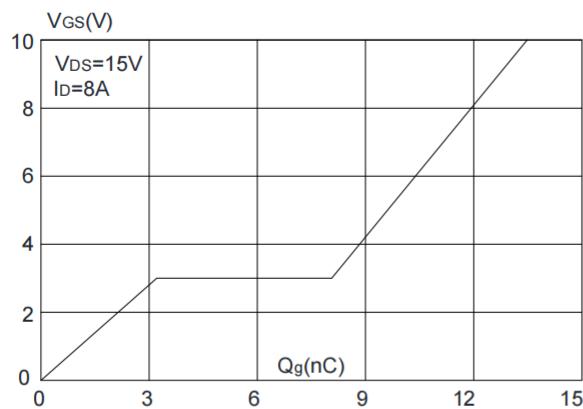
Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	30	---	---	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=30\text{V}$	---	---	1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{A}$	---	---	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{\text{GS}(\text{th})}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	1	1.5	2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On Resistance <sup>note3</sup>	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=15\text{A}$	---	6.5	8	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=10\text{A}$	---	10	14	
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	1110	---	pF
$C_{\text{oss}}$	Output Capacitance		---	180	---	
$C_{\text{rss}}$	Reverse Transfer Capacitance		---	150	---	
<b>Switching Characteristics</b>						
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DS}}=15\text{V}, I_{\text{D}}=12\text{A}$	---	15	---	ns
$t_r$	Rise Time		---	19	---	ns
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	35	---	ns
$t_f$	Fall Time		---	21	---	ns
$Q_g$	Total Gate Charge	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=15\text{V}, I_{\text{D}}=8\text{A}$	---	21	---	nC
$Q_{\text{gs}}$	Gate-Source Charge		---	2.35	---	nC
$Q_{\text{gd}}$	Gate-Drain "Miller" Charge		---	5.9	---	nC
<b>Drain-Source Diode Characteristics</b>						
$V_{\text{SD}}$	Diode Forward Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=12\text{A}$	---	---	1.2	V
$I_{\text{S}}$	Continuous Drain to Source Diode Forward Current		---	---	12	A

<b>I<sub>SM</sub></b>	Pulsed Drain to Source Diode Forward Current	---	---	60	A
<b>trr</b>	Reverse Recovery Time	$I_F=12A, dI/dt=100A/\mu s$	---	14	---
<b>Qrr</b>	Reverse Recovery Charge		---	4.1	nC

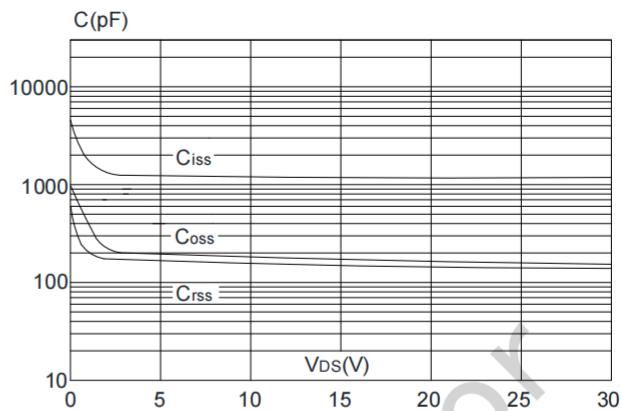
**Notes:**

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. EAS condition:  $T_J=25^\circ C$ ,  $V_{GS}=15V$ ,  $R_G=25\Omega$ ,  $L=0.5mH$ ,  $I_{AS}=12.6A$
3. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 0.5\%$

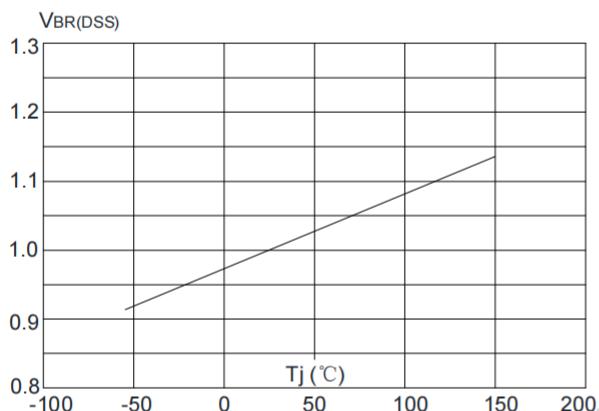
**Typical Characteristics:** ( $T_c=25^\circ C$  unless otherwise noted)

**Figure 1:** Output Characteristics

**Figure 2:** Typical Transfer Characteristics

**Figure 3:** On-resistance vs. Drain Current

**Figure 4:** Body Diode Characteristics



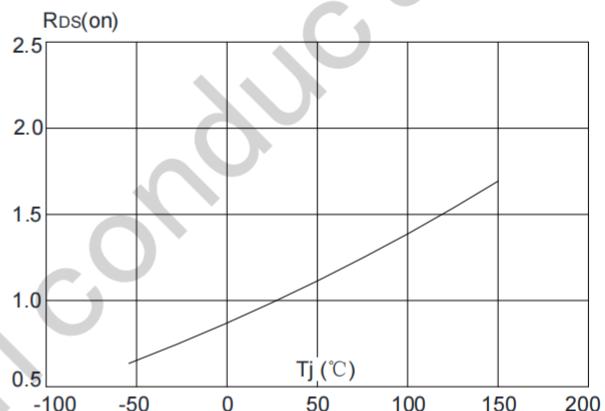
**Figure 5: Gate Charge Characteristics**



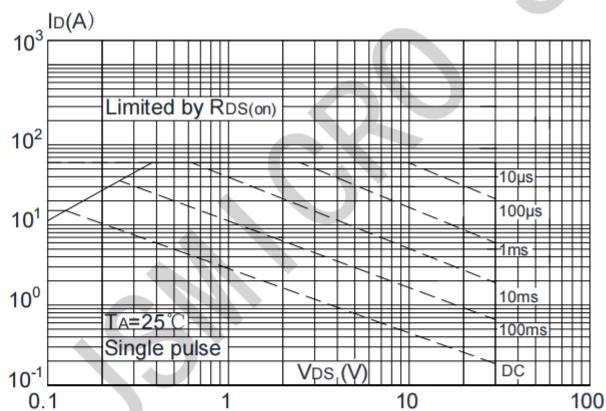
**Figure 6: Capacitance Characteristics**



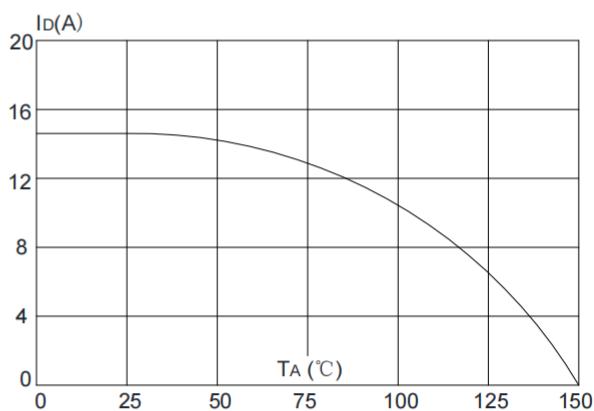
**Figure 7: Normalized Breakdown Voltage vs.**



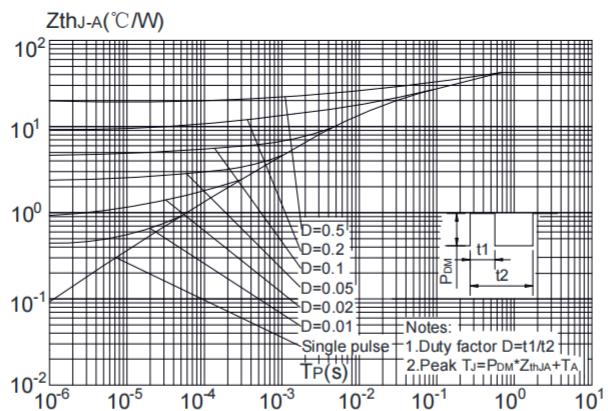
**Figure 8: Normalized on Resistance vs. Junction Temperature**



**Figure 9: Maximum Safe Operating Area**



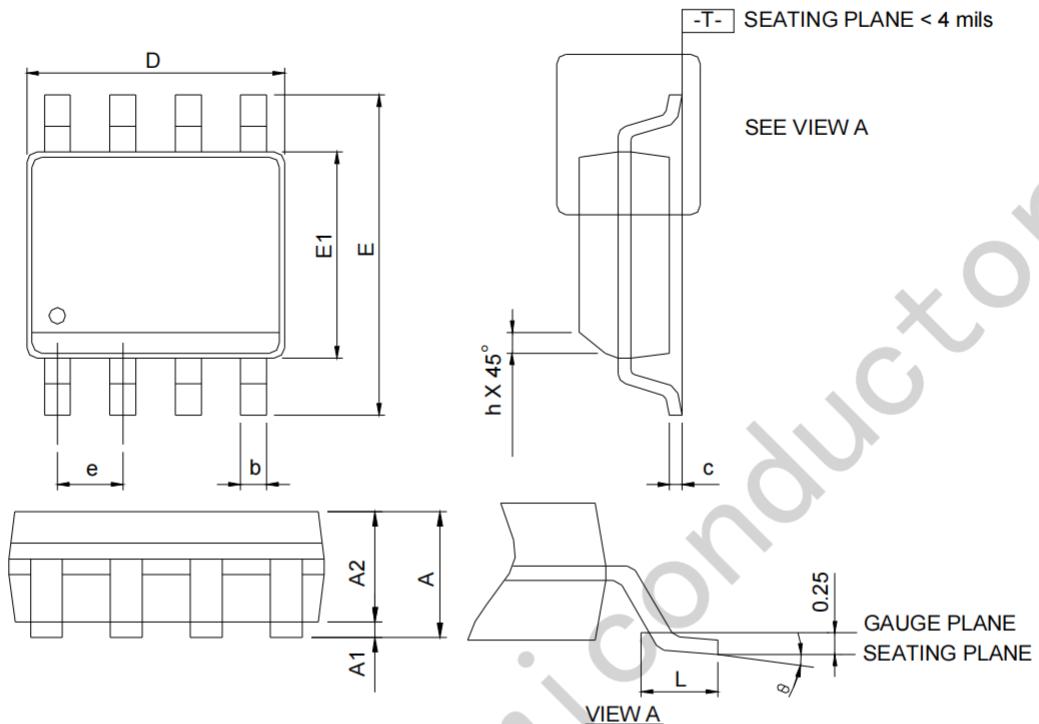
**Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature**



**Figure.11:** Maximum Effective  
Transient Thermal Impedance, Junction-to-Ambient

## Package Information

SOP-8



SYMBOL	SOP-8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	-	1.75	-	0.069
A1	0.10	0.25	0.004	0.010
A2	1.25	-	0.049	-
b	0.31	0.51	0.012	0.020
c	0.17	0.25	0.007	0.010
D	4.80	5.00	0.189	0.197
E	5.80	6.20	0.228	0.244
E1	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
h	0.25	0.50	0.010	0.020
L	0.40	1.27	0.016	0.050
θ	0°	8°	0°	8°

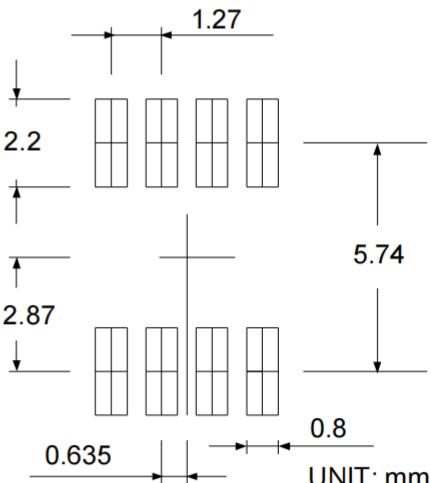
Note: 1. Follow JEDEC MS-012 AA.

 2. Dimension "D" does not include mold flash, protrusions or gate burrs.  
 Mold flash, protrusion or gate burrs shall not exceed 6 mil per side.

3. Dimension "E" does not include inter-lead flash or protrusions.

Inter-lead flash and protrusions shall not exceed 10 mil per side.

### RECOMMENDED LAND PATTERN



单击下面可查看定价，库存，交付和生命周期等信息

[>>JSMSEMI\(杰盛微\)](#)